## **Electro Magnetic Interference Testing and Engineering**

October 2, 2000

## Wireless Testing, Electrical Safety Testing, PCB Designs, and Hardware Design Engineering 360 Herndon Parkway, Suite 1400, Herndon, VA 20170

Tel: 703-689-0368, Fax: 703-689-2056

To: Mr. William H. Graff, NARTE Certified

Vice President of Engineering

AmericanTCB, Inc. 6731 Whittier Avenue McLean, VA 22101

RE: Samsung FCC ID: E2XSWL-2000E

Dear Graff,

1.

In response to your letter dated 10-2-00 the following are answers to your questions.

左 Corrected. See attached pdf file

2. Will correct for future applications.

٨ ⊱ Acrobat Document Acrobat Document 3. Corrected. See attached pdf file

4. Selection for the analyzer specification is from the DA 00-705 (Band Edge guide lines)

A

Corrected. See attached pdf file ( 5.

If you need any further information please call.

Desmond A. Fraser

President